

# FCZ120N40M2

## N沟道 eSiC碳化硅功率MOSFET

1200 V, 57 A, 40 mΩ



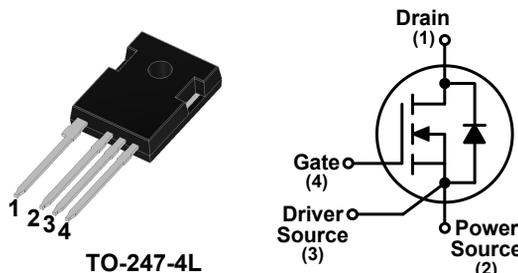
### Features

- 高开关频率，低栅极电荷
- 具有低反向恢复的快速体二极管
- 强大的雪崩能力
- 100% 雪崩测试
- 无铅、无卤且符合RoHS标准

$BV_{DSS, T_C=25^\circ C}$	$I_D, T_C=25^\circ C$	$R_{DS(on), typ}$	$Q_{g, typ}$
1200 V	57 A	40 mΩ	62 nC

### Benefits

- 提供效率提升
- 更高频率的适用性
- 增强功率密度
- 减少冷却工作量



### Applications

- 光伏逆变器
- 新能源汽车充电桩
- UPS
- 工业电源



### 绝对最大额定值 ( $T_C = 25^\circ C$ , 除非另有说明)

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain to Source Voltage	1200	V
$V_{GS}$	Gate to Source Voltage (DC)	-10 / +22	V
$V_{GSop}$	Recommended Operation Value	-5...-3 / +18	V
$I_D$	Drain Current	Continuous ( $T_C = 25^\circ C$ )	57
		Continuous ( $T_C = 100^\circ C$ )	40
$I_{DM}$	Drain Current	Pulsed (Note1)	142
$P_D$	Power Dissipation	( $T_C = 25^\circ C$ )	288
		Derate Above $25^\circ C$	1.9
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to 175	$^\circ C$
$T_L$	Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds	260	$^\circ C$

### 热特性

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.52	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

### 封装标识和订购信息

Part Number	Top Marking	Package	Packing Method	Quantity
PCZ120N40M2	PCZ120N40M2	TO-247-4L	Tube	30 units

电特性 (T<sub>C</sub> = 25°C 除非另有说明)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
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Off Characteristics

BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	1200			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V		1	100	μA
		V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 175°C		10		
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = +22 V, V <sub>DS</sub> = 0 V			+100	nA
		V <sub>GS</sub> = -10 V, V <sub>DS</sub> = 0 V			-100	

On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 10 mA (tested after V <sub>GS</sub> = 22 V, 1 ms pulse)	2.0	3.0	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 18 V, I <sub>D</sub> = 28 A		40.0	56.0	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 28 A, T <sub>J</sub> = 175°C		64.0		
		V <sub>GS</sub> = 15 V, I <sub>D</sub> = 28 A		55.5		
g <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 28 A		16.9		S

Dynamic Characteristics

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V, f = 250 kHz		1668		pF
C <sub>oss</sub>	Output Capacitance			105		
C <sub>riss</sub>	Reverse Capacitance			4		
E <sub>oss</sub>	Stored Energy in Output Capacitance	V <sub>DS</sub> = 0 V to 800 V, V <sub>GS</sub> = 0 V		42		μJ
C <sub>o(er)</sub>	Energy Related Output Capacitance			132		pF
C <sub>o(tr)</sub>	Time Related Output Capacitance			201		
Q <sub>g(tot)</sub>	Total Gate Charge	V <sub>DS</sub> = 800 V, I <sub>D</sub> = 28 A, V <sub>GS</sub> = -3 V / 18 V, Inductive load		62		nC
Q <sub>gs</sub>	Gate to Source Charge			20		
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			14		
R <sub>G</sub>	Internal Gate Resistance	f = 1 MHz, V <sub>AC</sub> = 30 mV		3.0		Ω

Switching Characteristics

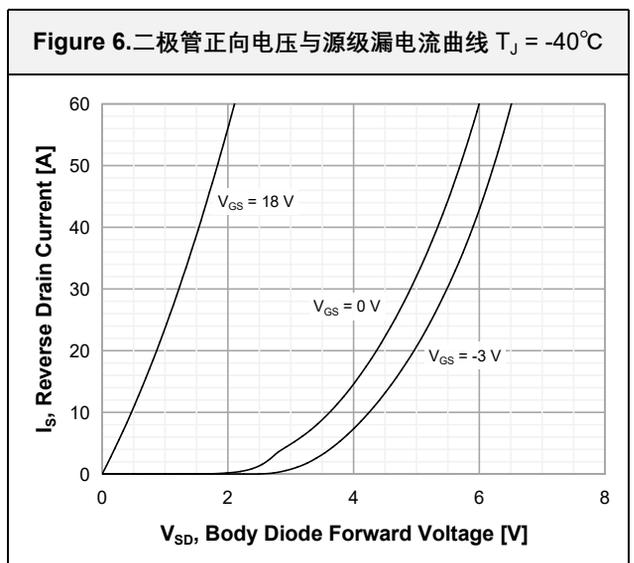
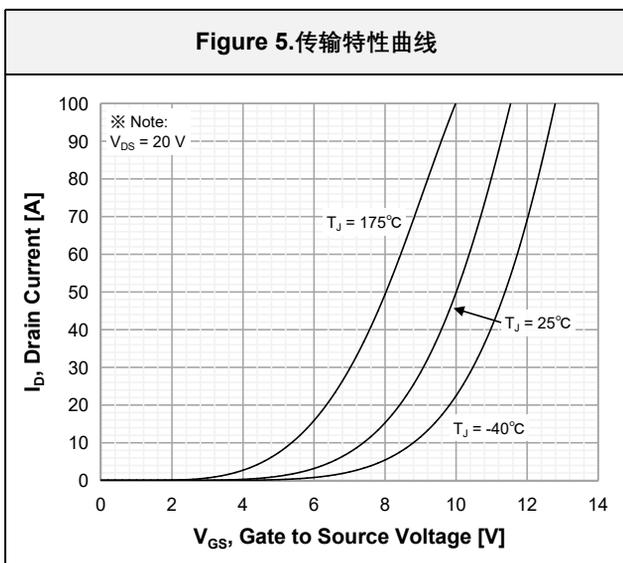
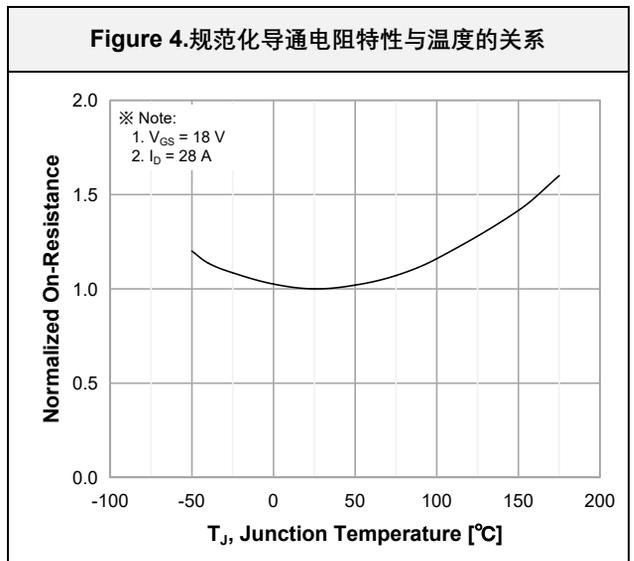
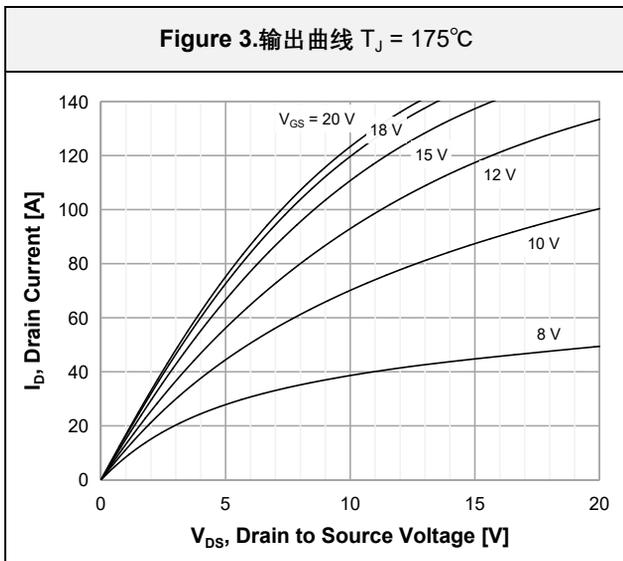
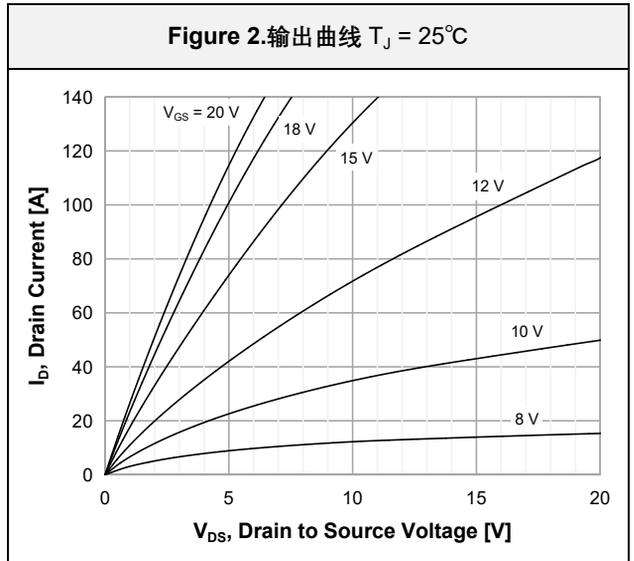
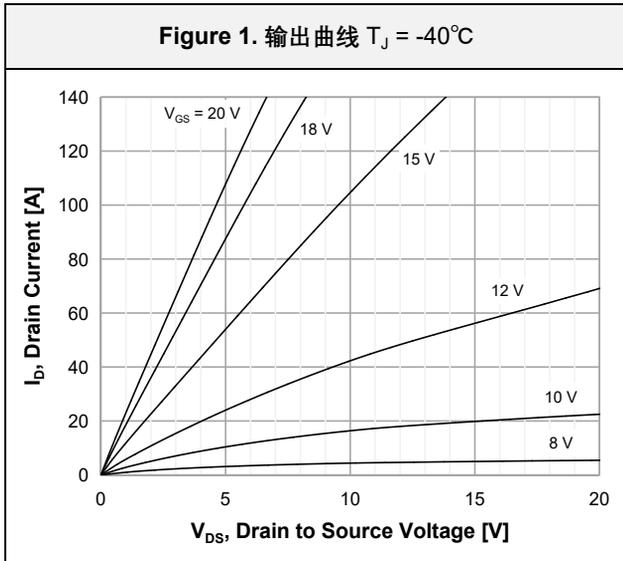
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 800 V, I <sub>D</sub> = 28 A, V <sub>GS</sub> = -3 V / 18 V, R <sub>G</sub> = 6.8 Ω, FWD : PCH120S20D1, Inductive load		19		ns
t <sub>r</sub>	Turn-On Rise Time			15		
t <sub>d(off)</sub>	Turn-Off Delay Time			35		
t <sub>f</sub>	Turn-Off Fall Time			8		
E <sub>on</sub>	Turn-on Switching Energy			158		μJ
E <sub>off</sub>	Turn-off Switching Energy			100		
E <sub>tot</sub>	Total Switching Energy			258		

**Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>Source-Drain Diode Characteristics</b>						
$I_S$	Continuous Diode Forward Current	$V_{GS} = -3\text{ V}$			57	A
$I_{SM}$	Pulsed Diode Forward Current	$V_{GS} = -3\text{ V}$ (Note1)			142	
$V_{SD}$	Diode Forward Voltage	$V_{GS} = -3\text{ V}, I_{SD} = 28\text{ A}$		4.3		V
$t_{rr}$	Reverse Recovery Time	$V_{DD} = 800\text{ V}, I_{SD} = 28\text{ A},$ $di_F/dt = 3000\text{ A}/\mu\text{s}$ , Includes $Q_{oss}$		15		ns
$Q_{rr}$	Reverse Recovery Charge			219		nC
$I_{rm}$	Peak Reverse Recovery Current			24		A

※注1：受最高结温限制

典型性能特性



典型性能特性

Figure 7. 二极管正向电压与源级漏电流曲线  $T_J = 25^\circ\text{C}$

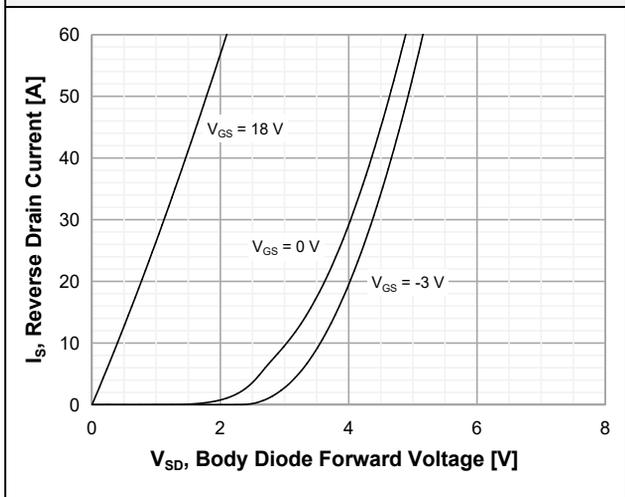


Figure 8. 二极管正向电压与源级漏电流曲线  $T_J = 175^\circ\text{C}$

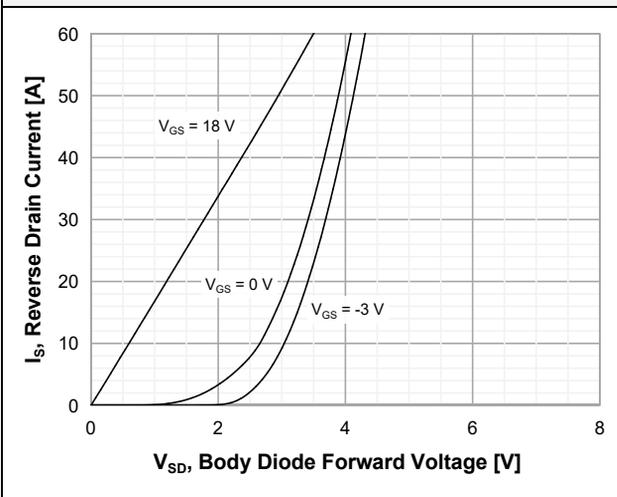


Figure 9. 阈值电压与温度关系

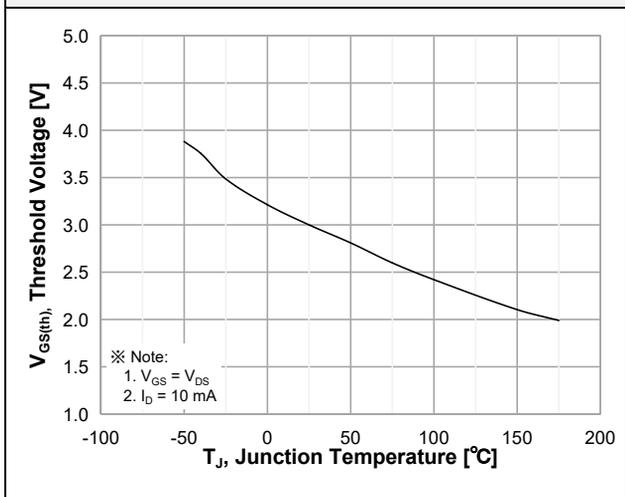


Figure 10. 栅极电荷特性

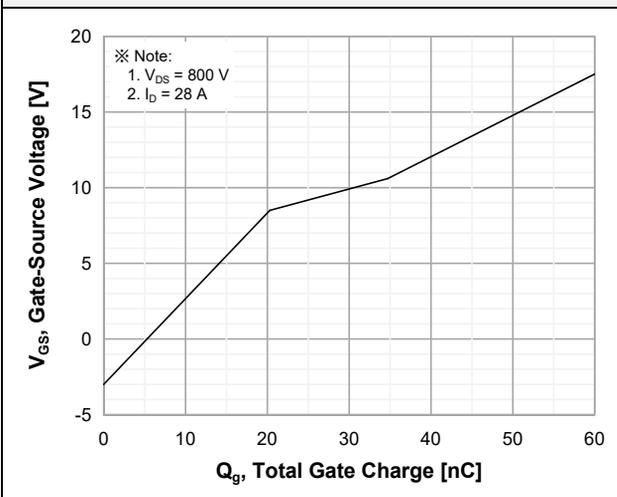


Figure 11. 输出电容中的储存能量

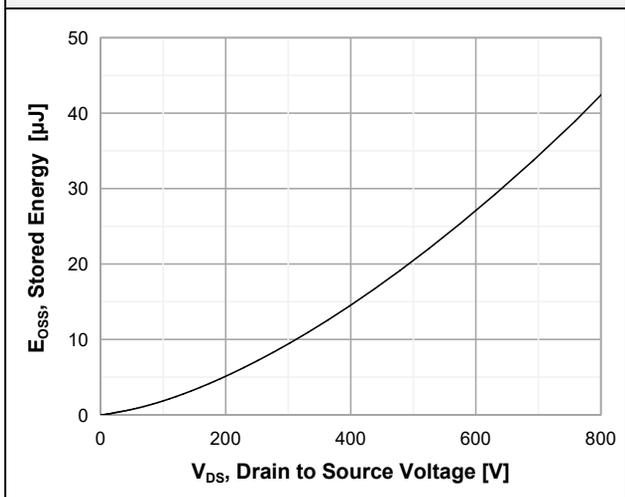
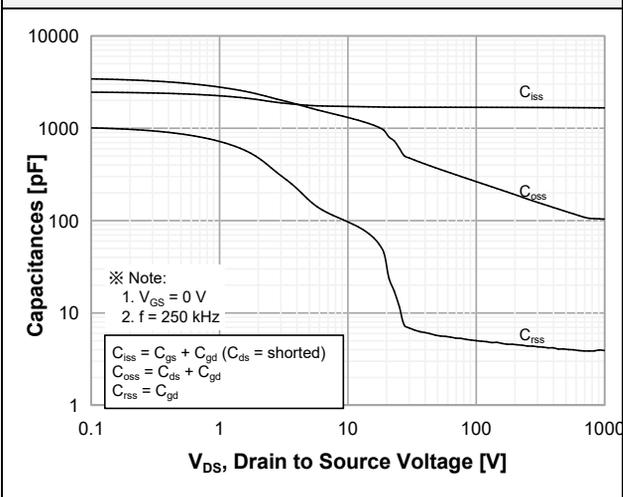


Figure 12. 电容特性



典型性能特性

Figure 13. 连续漏极电流降额与外壳温度

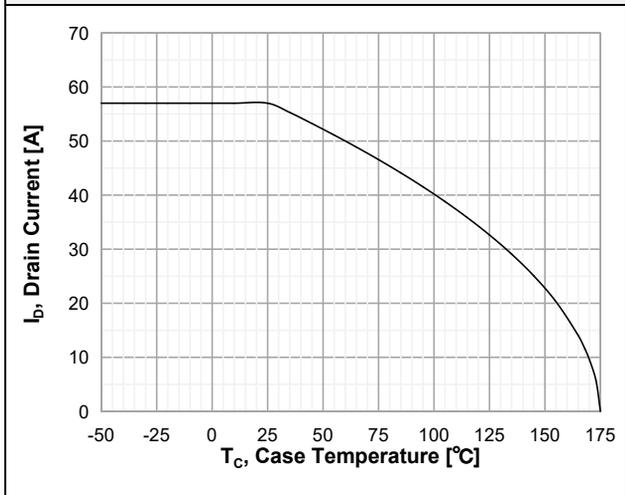


Figure 14. 最大功耗降额与外壳温度

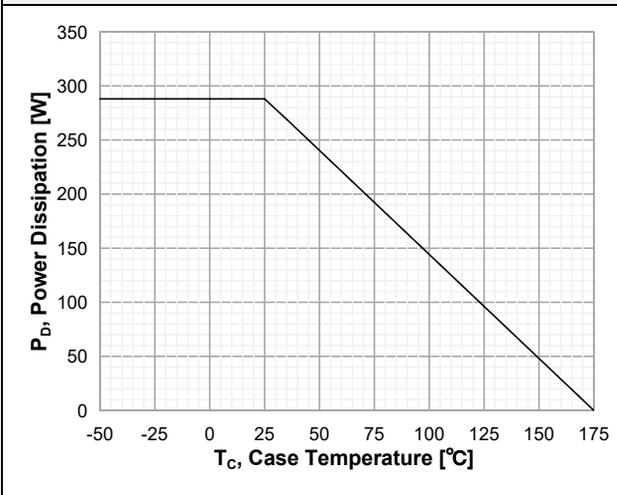


Figure 15. Typ. 开关损耗与漏极电流

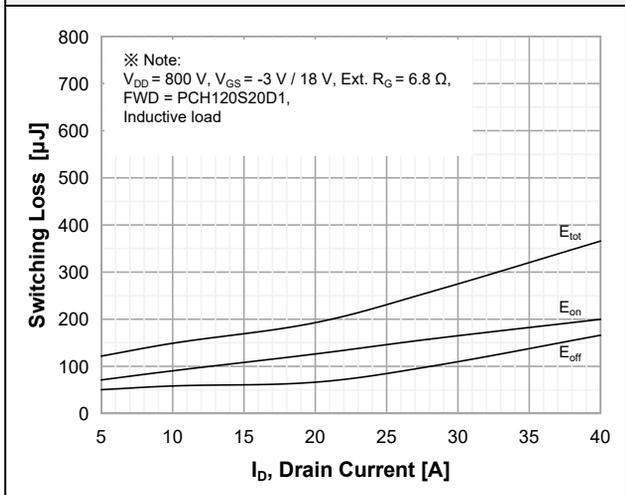


Figure 16. Typ. 开关损耗与栅极电阻

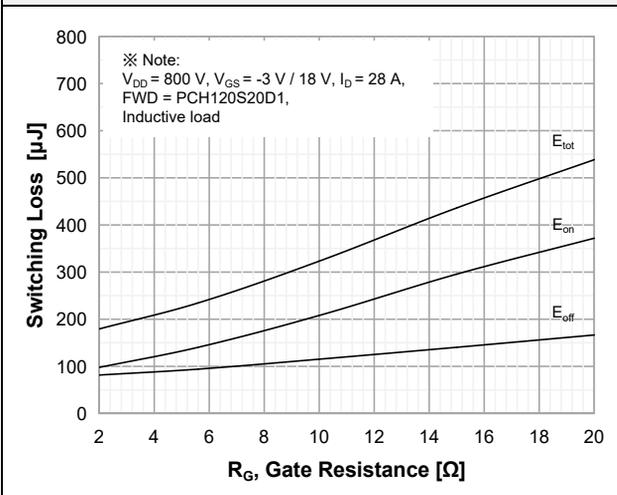


Figure 17. Typ. 开关损耗与漏极电流

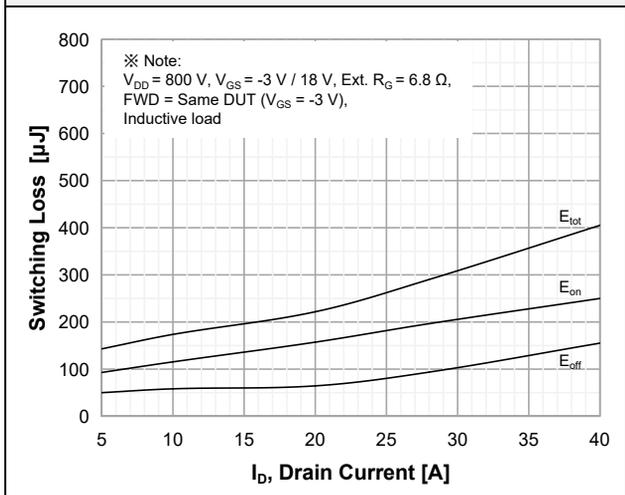
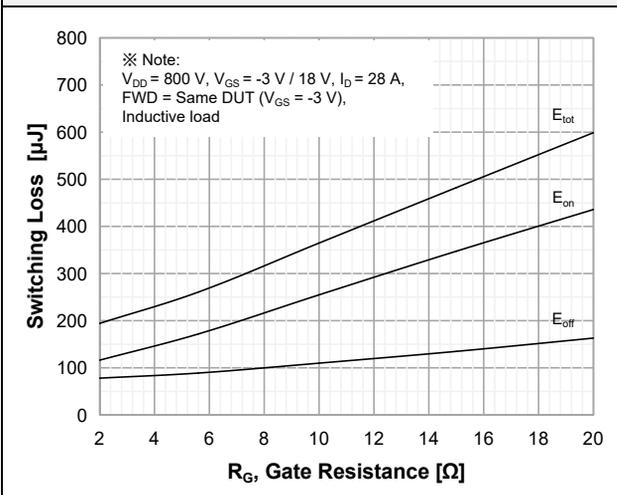
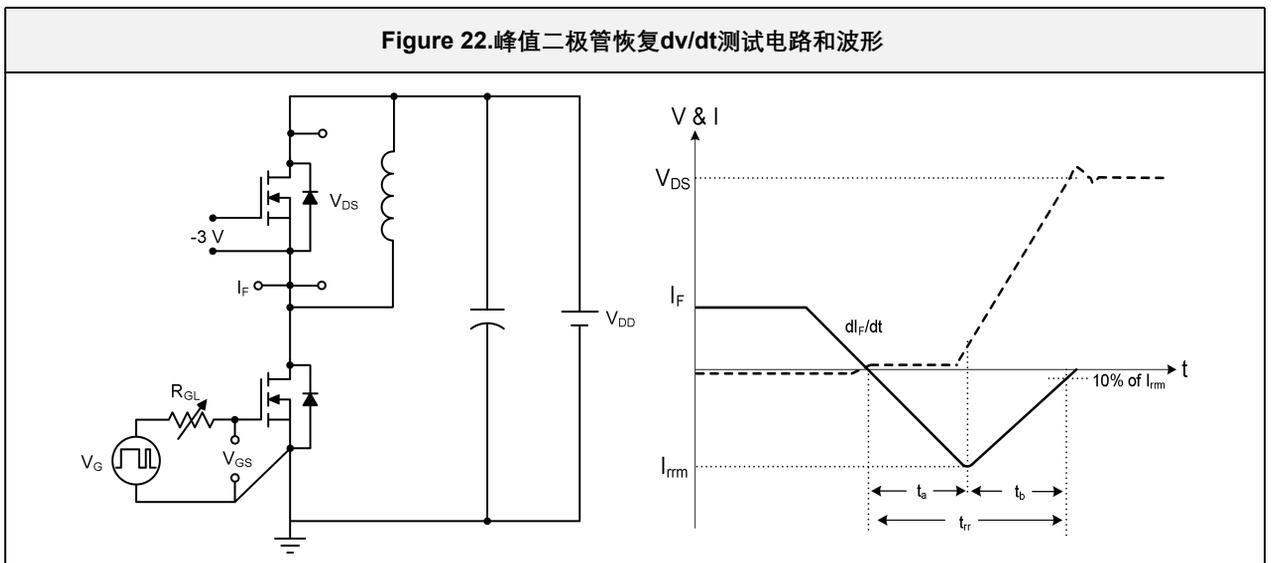
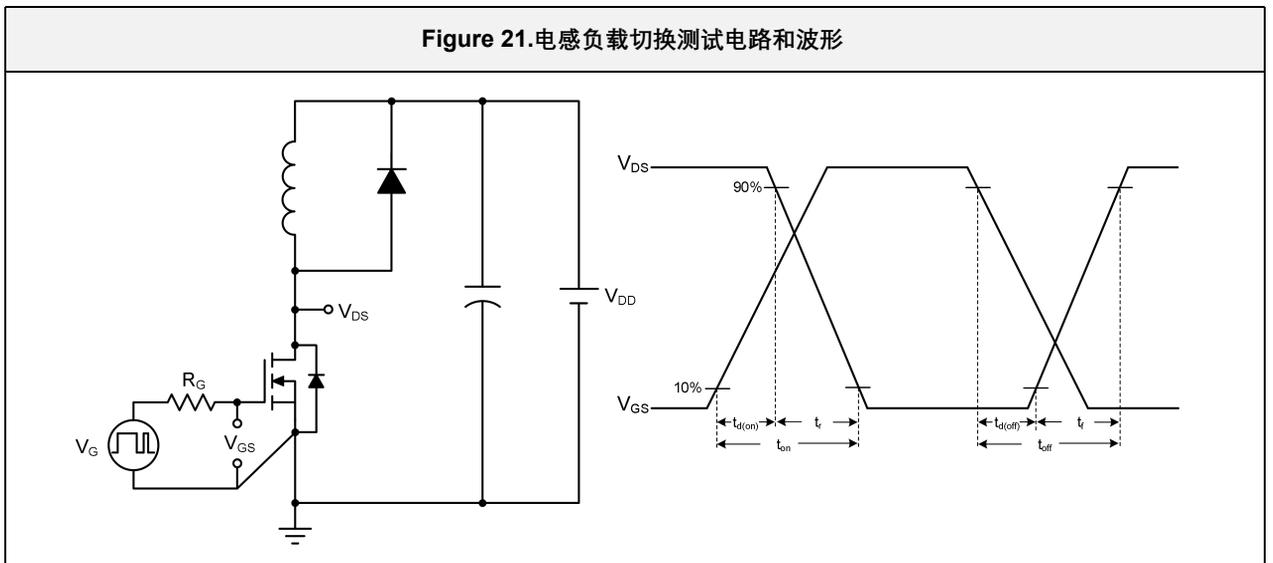
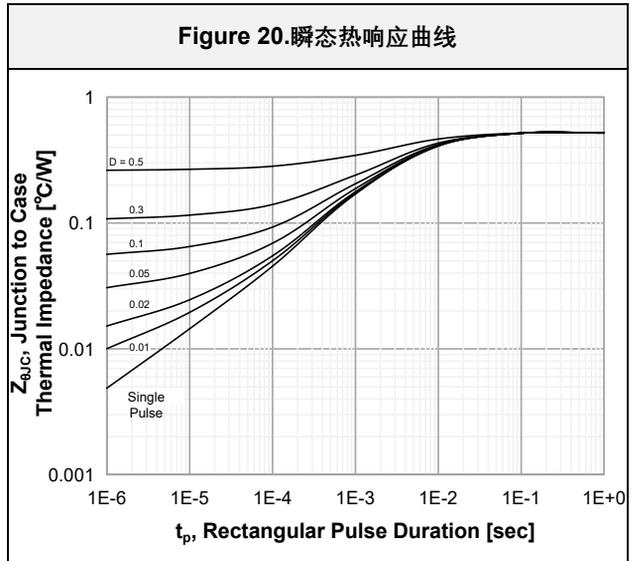
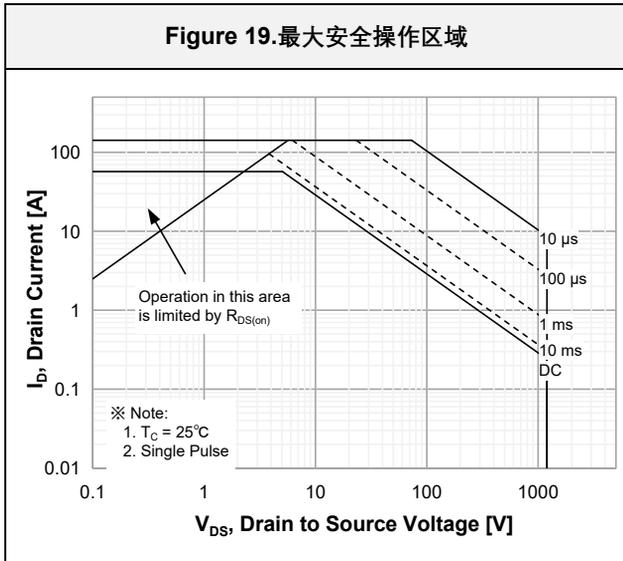


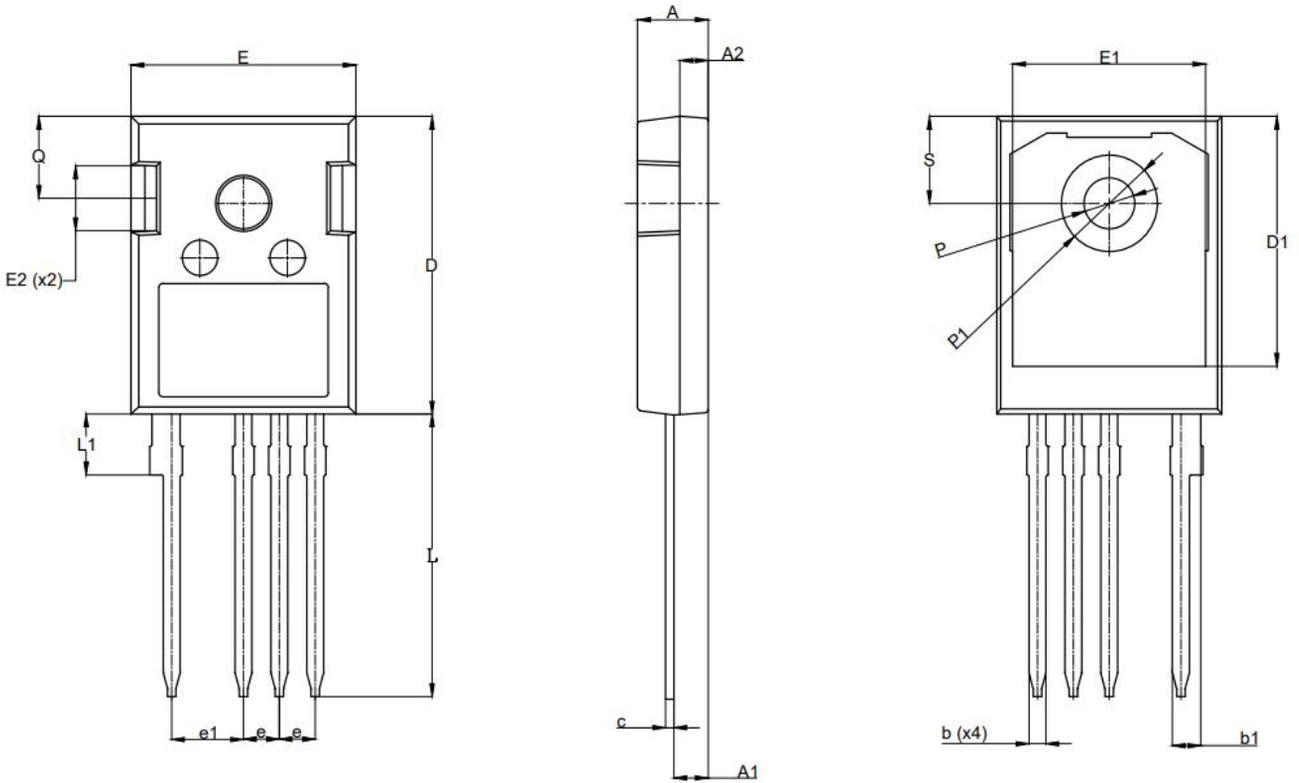
Figure 18. Typ. 开关损耗与栅极电阻



典型性能特性



Package Outlines  
**TO-247-4L**



SYMBOL	Common		
	DIMENSIONS MILLIMETER		
	MIN.	NOM.	MAX.
A	4.80	5.00	5.20
A1	2.29	2.42	2.54
A2	1.90	2.00	2.10
b	1.10	1.20	1.30
b1	1.86	2.01	2.15
c	0.50	0.60	0.70
D	20.90	21.00	21.10
D1	17.43	17.63	17.83
E	15.75	15.94	16.13
E1	13.46	13.66	13.86
E2	4.32	4.58	4.83
e	2.54 BSC.		
e1	5.08 BSC.		
L	19.80	19.95	20.10
L1	-	-	4.30
P	3.56	3.61	3.66
P1	6.75	6.80	6.85
Q	5.38	5.79	6.20
S	6.15 BSC.		

\* Dimensions in millimeters